

FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE STATEMENT BY APPLICANT	ATTY. DOCKET NO.: JCLA16514	APPLICATION No.: 10/529,376
	APPLICANT: HIROSHI SAWADA et al.	
	FILING DATE: 9/20/2005	GROUP: 3742

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE (IF APPROPRIATE)
/SMH/	5,072,091	12/10/91	Itsuo Nagata et al.	219	121.68	
/SMH/	5,417,896	05/23/95	Gerd Fischer et al.	264	22	
/SMH/						

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	PUBLICATION DATE	COUNTRY	CLASS	SUBCLASS	T
/SMH/	4-91875	03/25/92	Japan			✓
/SMH/	59-165428	09/18/84	Japan			✓
/SMH/	59-168403	09/22/84	Japan			✓
/SMH/	WO 02/16149	02/28/02	PCT			✓

NON PATENT LITERATURE DOCUMENTS

EXAMINER INITIAL	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or county where published.	T
/SMH/		A.V. DEMCHUK et al., "Formation of periodic surface structures on silicon by millisecond-pulsed laser light" Soviet Physics Technical Physics, American Institute of Physics, New York, Vol. 31, No. 4, April 01, 1986, page 494-495	✓
/SMH/		MATTHIAS BOLLE et al., "Submicron periodic structures produced on polymer surfaces with polarized excimer laser ultraviolet radiation" Applied Physics Letters, AIP, American Institute of Physics, Nelville, NY, Vol. 60, No. 6, February 10, 1992, pages 674-676	✓
/SMH/		P. MILANI et al., "Surface periodic structure induced by pulsed laser irradiation of fullerite" Applied Physics Letter, AIP, American Institute of Physics, Vol. 68, No. 13, March 25, 1996, page 1769-1771	✓

EXAMINER /Samuel M. Heinrich/ (04/16/2009)	DATE CONSIDERED
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